

<b>Notice of References Cited</b>	Application/Control No. 09/762,472		Applicant(s)/Patent Under Reexamination EDER ET AL.	
	Examiner Li B. Zhen		Art Unit 2194	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-H0,001,898	10-2000	Doughty et al.	455/466
*	B	US-6,009,093	12-1999	Choe, Jae-Weon	370/376
	C	US-			
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	K	US-			
	L	US-			
	M	US-			

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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